

Closed-Loop Analysis of Load-Induced Amplifier Stability Issues Using Z_{OUT}

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ABSTRACT

This application note discusses techniques using amplifier closed-loop output impedance (Z_{OUT}) to solve load-dependent stability issues.

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1 Introduction

Amplifier stability is load-dependent. An amplifier that is stable with a resistive load may ring or oscillate with a reactive load.

The traditional method for evaluating the impact of loading on the stability of a closed-loop amplifier involves analyzing Bode plots of the amplifier loaded loop-gain function. The load element interacts with the amplifier open-loop output impedance (Z_O) to alter the frequency response of the amplifier loop gain function, and the available stability margins. Analyzing these load-induced changes in loop gain requires open-loop conditions or *breaking* the amplifier feedback loop. Breaking the loop is not possible in the case of closed-loop amplifier devices such as current-sense amplifiers because the feedback loop is internal to the device and cannot be manipulated.

Nevertheless, there is a closed-loop amplifier property that is affected by changes to loop gain, and can be used for stability analysis without breaking the loop. This property is the amplifier closed-loop output impedance (Z_{OUT}), an increasingly common specification in the data sheets and SPICE macro-models of TI current sensing and precision amplifier products. This application report demonstrates through TINA-TI SPICE simulations a method of using Z_{OUT} to analyze the stability of an amplifier load transient response under various load conditions.

2 Basic Properties of Electrical Impedance

2.1 Measuring Impedance

Before delving into the details of closed-loop stability analysis, a review of a few basic concepts relating to electrical impedance is helpful. Impedance is the current-to-voltage transfer gain over frequency, of an electrical circuit or component. The stimulus is an ac small-signal current input of variable frequency, and the response is the resulting change in voltage at the test frequency. Impedance is then calculated by applying Ohm's law to the recorded changes in current and voltage.

Figure 1 depicts the impedance test circuit. The unknown impedance (Z_{BLOCK}) is excited by an ac small-signal current (I_{LOAD}) of frequency f , with the other terminal driven to a fixed dc voltage (V_{DC}). If $V_{DROP}(f)$ and $I_{LOAD}(f)$ are both measured at time instants t_1 and t_2 , then by Ohm's law, the following two equations are derived:

$$V_{DROP}(f)(t_1) = V_{DC} + I_{LOAD}(f)(t_1) \times Z_{BLOCK}(f) \quad (1)$$

$$V_{DROP}(f)(t_2) = V_{DC} + I_{LOAD}(f)(t_2) \times Z_{BLOCK}(f) \quad (2)$$

Subtracting Equation 2 from Equation 1 and solving for $Z_{BLOCK}(f)$ yields Equation 3.

$$Z_{BLOCK}(f) = \frac{V_{DROP}(f)(t_1) - V_{DROP}(f)(t_2)}{I_{LOAD}(f)(t_1) - I_{LOAD}(f)(t_2)} = \frac{\Delta V_{DROP}(f)}{\Delta I_{LOAD}(f)} \quad (3)$$

$\Delta V_{DROP}(f)$ and $\Delta I_{LOAD}(f)$ represent *changes* in V_{DROP} and I_{LOAD} between time instants t_1 and t_2 . Therefore, there is no difference in the value of ΔV_{DROP} whether V_{DROP} is measured with respect to V_{DC} or with respect to GND.

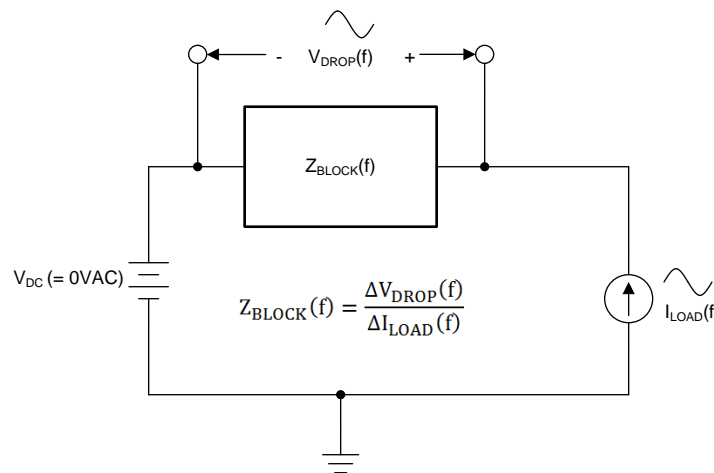


Figure 1. Impedance Test Circuit

Figure 2 shows the test circuit of Figure 1 configured for measuring the impedance of a capacitor (C_1). In this case, the response is measured directly relative to GND. The 1-G Ω resistor (R_1) is for simulation only and is required for dc convergence. Capacitor C_1 can be substituted with any two-terminal device to measure the impedance of the circuit.

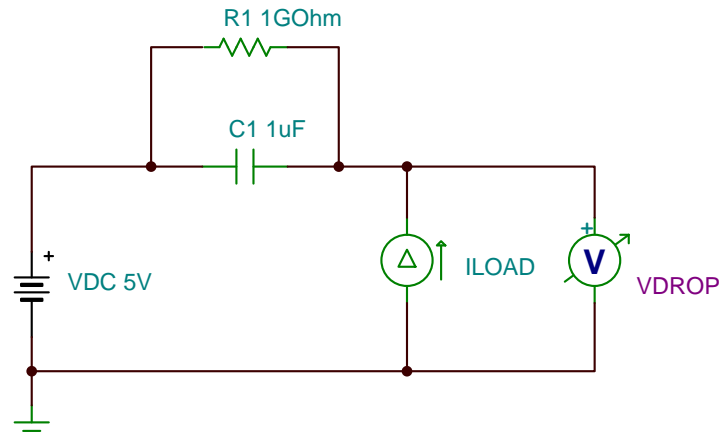


Figure 2. Measuring $Z_{\text{CAPACITOR}}$

2.2 Visualizing Impedance Using Bode Plots

Impedance, like any ac gain transfer function, is a complex function of frequency having magnitude and phase, and usually represented using Bode plots to simplify analysis. Figure 3 shows the Bode magnitude and phase plots of the ideal resistive (purely real) and reactive (purely imaginary) impedance elements.

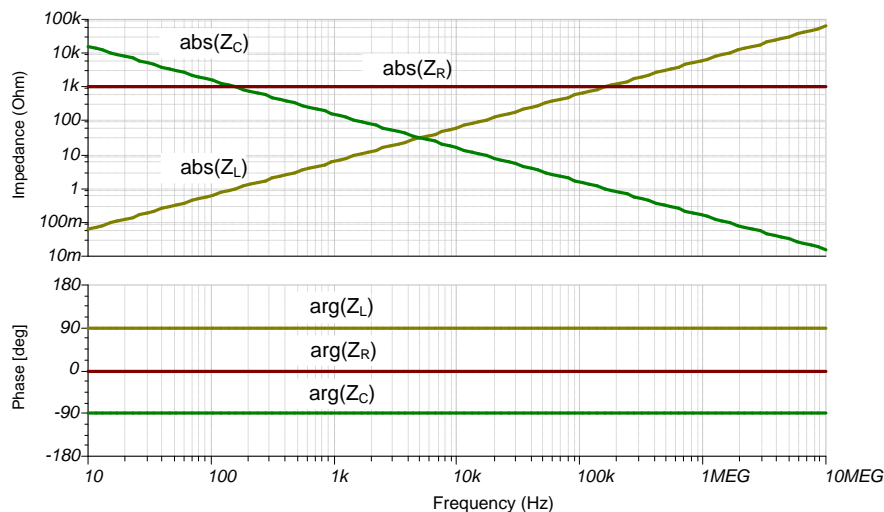


Figure 3. Bode Plots of Ideal Resistive and Reactive Impedances

Observe that the linear magnitude characteristic of the capacitor over frequency is the result of using logarithmic scales for the vertical and horizontal axes.

2.3 Poles of Z_{EQ} Determine Load Transient Stability

Impedances combine in series or parallel configurations. The combination of resistive and reactive elements in a circuit produces poles and zeros in the Thévenin equivalent impedance function (Z_{EQ}). The locations of the poles of Z_{EQ} in the complex s-plane determine the stability of the circuit response to load transients. For a detailed review of pole-zero analysis of system transfer functions, see [Understanding Poles and Zeros](#).

For most circuits, a stable transient response is one that converges asymptotically to a finite, steady-state value without ringing. Based on [Figure 4](#), the required transient response is obtained from a transfer function (Z_{EQ}) with poles that are not only all in the left half plane (LHP), but are also purely real (that is, lie on the negative real axis marked by the red line in [Figure 4](#)).

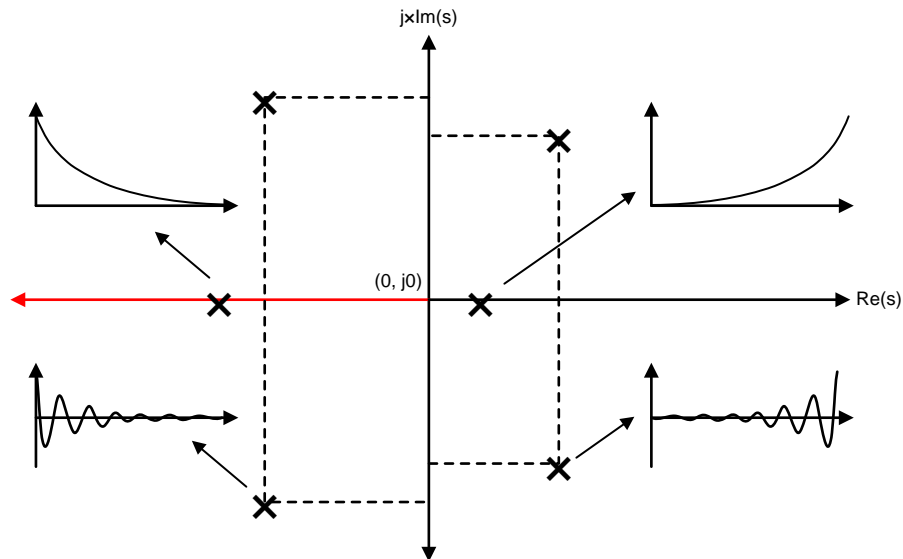


Figure 4. Transient Response Based on Various Pole Locations in S-Plane

2.4 Finding Poles and Zeros of Z_{EQ}

The poles and zeros of Z_{EQ} can be found by solving for the roots of the denominator and numerator, respectively. For example, the Z_{EQ} transfer function of the circuit in Figure 5 is given by Equation 4.

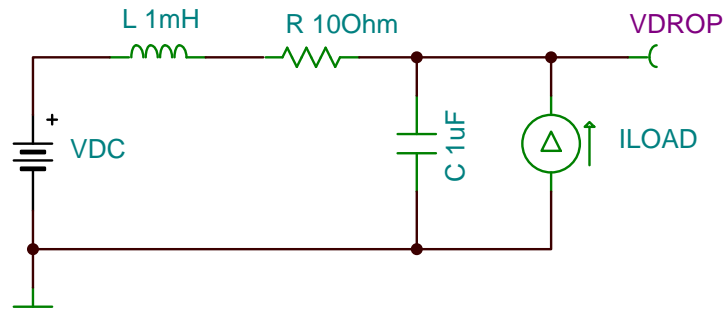


Figure 5. Example Circuit With Both Series and Parallel Impedance Combinations

$$Z_{EQ}(s) = (Z_L + Z_R) \parallel Z_C = \frac{R + sL}{1 + sRC + s^2 LC} \quad (4)$$

Table 1 summarizes the procedure to solve for the poles and zeros of Z_{EQ} .

Table 1. Computation of Poles and Zeros of Equation 4

Poles of Z_{EQ}	Zeros of Z_{EQ}
Denominator($Z_{EQ}(s)$) = 0 $\Rightarrow 1 + sRC + s^2 LC = 0$ $\Rightarrow s_{p1,p2} = -\frac{R}{2L} \pm \sqrt{\left(\frac{R}{2L}\right)^2 - \frac{1}{LC}}$	Numerator($Z_{EQ}(s)$) = 0 $\Rightarrow R + sL = 0$ $\Rightarrow s_{z1} = -\frac{R}{L}$
Substituting Values of R, C and L From Figure 5:	
$s_{p1,p2} = (-5000 \pm j31225) \frac{\text{rad}}{\text{s}}$ $f_{p1,p2} = \frac{ \text{Im}(s_{p1,p2}) }{2\pi} = 4.97 \text{ kHz}$	$s_{z1} = (-1000 + j0) \frac{\text{rad}}{\text{s}}$ $f_{z1} = \frac{ \text{Re}(s_{z1}) }{2\pi} = 1.59 \text{ kHz}$

The following observations can be made based on [Table 1](#):

- Z_{EQ} has a single real LHP zero (that is, has negative real part) corresponding to $f = 1.59$ kHz.
- Z_{EQ} has a pair of LHP complex conjugate poles corresponding to $f = 4.97$ kHz, indicating an oscillatory transient response with 4.97 kHz frequency, as shown in [Figure 6](#).

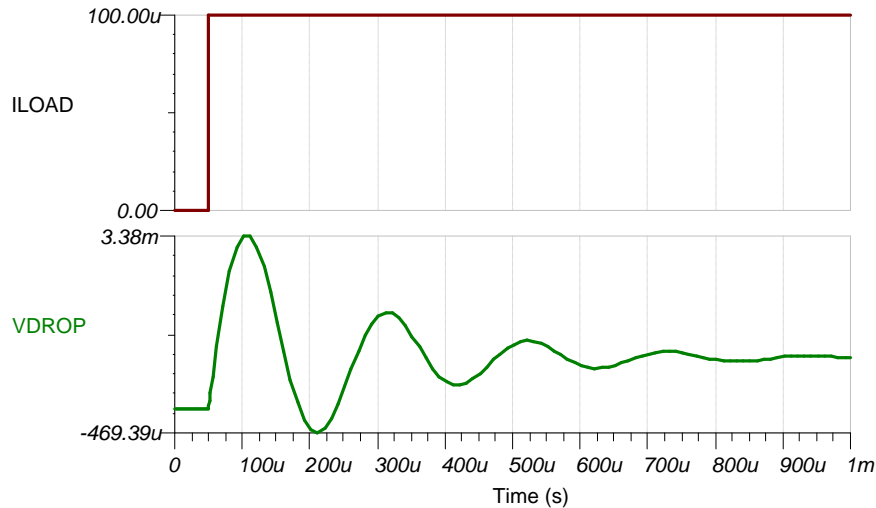


Figure 6. Unstable Transient Response of Circuit in [Figure 5](#)

In many cases, the poles and zeros of Z_{EQ} can also be identified graphically using Bode plots. The general shape of the Z_{EQ} magnitude plot can be obtained by superimposing the magnitude plots of the individual impedances and tracing the path of the *dominant* impedance at each frequency. Impedances with higher magnitude dominate in a series combination, and impedances with lower magnitude dominate in a parallel combination. [Figure 7](#) shows an example.

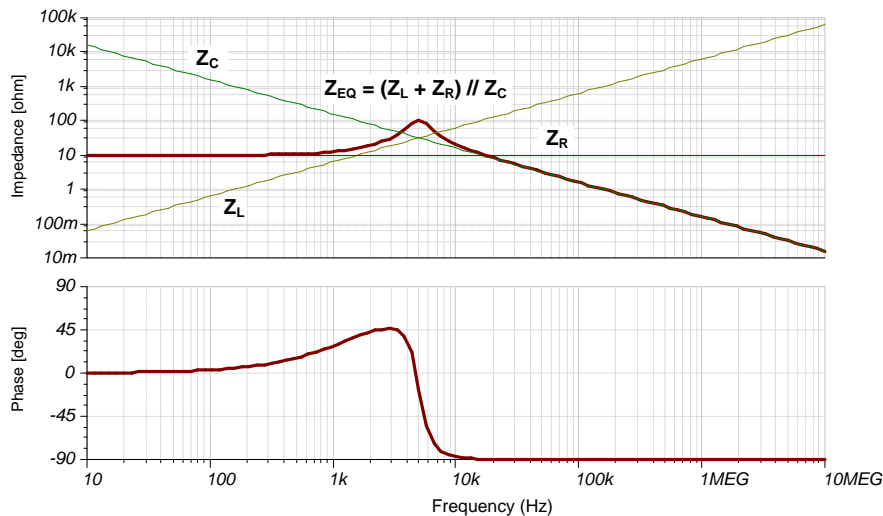


Figure 7. Bode Plots of Z_{EQ} for Circuit in [Figure 5](#)

After the shape of the Z_{EQ} magnitude plot has been constructed, standard rules (summarized in Table 2) can be applied to identify whether the break frequencies correspond to poles or zeros, as well as whether they are real or complex.

Table 2. Pole and Zero Signatures on Bode Plots

Change in Slope of Magnitude Plot Around f_{BREAK}	Change in Phase Around f_{BREAK}	f_{BREAK} Corresponds to
20 dB/decade	45°/decade over $0.1f_{BREAK} < f < 10f_{BREAK}$	Single real LHP zero
$N \times (20 \text{ dB/decade})$	$N \times (45^\circ/\text{decade})$ over $0.1f_{BREAK} < f < 10f_{BREAK}$	N real repeated LHP zeros
-20 dB/decade	-45°/decade over $0.1f_{BREAK} < f < 10f_{BREAK}$	Single Real LHP pole
$N \times (-20 \text{ dB/decade})$	$N \times (-45^\circ/\text{decade})$ over $0.1f_{BREAK} < f < 10f_{BREAK}$	N real repeated LHP poles
Peak	Sharp decrease	Pair of complex conjugate LHP poles
Notch	Sharp increase	Pair of complex conjugate LHP zeros
20 dB/decade	-45°/decade over $0.1f_{BREAK} < f < 10f_{BREAK}$	Single real RHP zero
-20 dB/decade	45°/decade over $0.1f_{BREAK} < f < 10f_{BREAK}$	Single real RHP pole
Peak	Sharp increase	Pair of complex conjugate RHP poles
Notch	Sharp decrease	Pair of complex conjugate RHP zeros

Applying the rules specified in Table 2 to Figure 7, Z_{EQ} has a real LHP zero around the $Z_R - Z_L$ matching frequency (1.59 kHz), and a pair of complex conjugate poles around the $Z_L - Z_C$ matching frequency (4.97 kHz). In this case, the complex conjugate poles physically represent resonance due to the $Z_L - Z_C$ interaction when I_{LOAD} stimulates the circuit.

2.5 Stabilizing the Load Transient Response

Ringling can be eliminated by making sure that Z_{EQ} has no complex poles. Referring to the expression for $s_{p1,p2}$ in Table 1, the poles of Z_{EQ} are real if the quantity under the square root is positive. Assuming the values of L and C are retained, and the value of R is varied, Equation 5 specifies the values of R that stabilize the circuit.

$$\left(\frac{R}{2L}\right)^2 - \frac{1}{LC} \geq 0$$

$$R \geq 2 \times \sqrt{\frac{L}{C}} = 63.25 \ \Omega \tag{5}$$

Table 3 computes the effect of setting $R = 2 \times \sqrt{L/C}$ on the poles and zeros of Z_{EQ} .

Table 3. Z_{EQ} Poles and Zeros With $R = 2 \times \sqrt{L/C}$

Poles of Z_{EQ}	Zeros of Z_{EQ}
$s_{p1,p2} = -\frac{R}{2L} \pm \sqrt{\left(\frac{R}{2L}\right)^2 - \frac{1}{LC}} = -\frac{1}{\sqrt{LC}}$	$s_{z1} = -\frac{R}{L} = -\frac{2}{\sqrt{LC}} = 2 \times s_{p1,p2}$
Substituting values of L, and C from Figure 5:	
$s_{p1,p2} = (-31622 \pm j0) \frac{\text{rad}}{\text{s}}$ $f_{p1,p2} = \frac{ \text{Re}(s_{p1,p2}) }{2\pi} = 5.03 \text{ kHz}$	$s_{z1} = (-63245 + j0) \frac{\text{rad}}{\text{s}}$ $f_{z1} = \frac{ \text{Re}(s_{z1}) }{2\pi} = 10.06 \text{ kHz}$

Z_{EQ} no longer contains complex poles, and [Figure 8](#) confirms the circuit's stable load transient response.

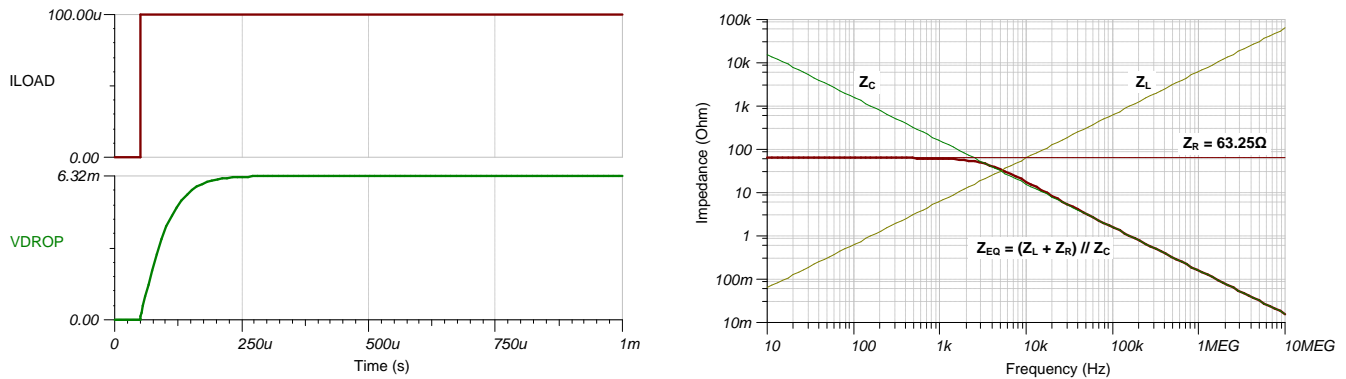


Figure 8. RLC Circuit of [Figure 5](#) is Stable With $R = 2 \times \sqrt{LC}$

In most cases, Bode plots can also be used in an iterative fashion to improve stability. The goal is to eliminate any peaks in the Z_{EQ} magnitude plot. Peaks caused by resonant LC interactions are eliminated by increasing the value of the resistance. [Figure 9](#) illustrates the effect of iteratively increasing the value of R in the [Figure 5](#) circuit on the magnitude peak and step response. The steady-state error is increasing because I_{LOAD} is a step function and nonzero at steady-state, thus creating a bigger voltage drop as the series resistance is increased.

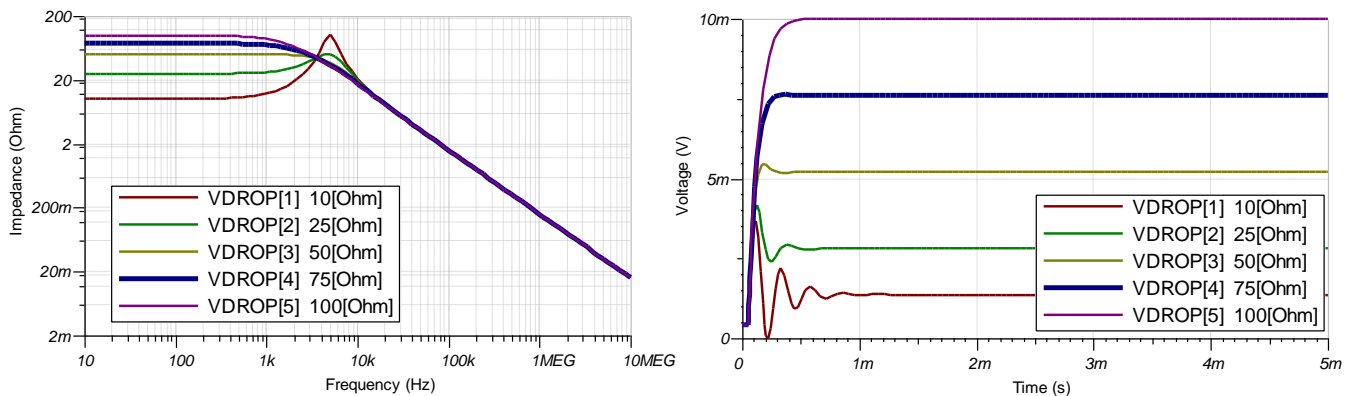


Figure 9. Iterative Stability Improvement of [Figure 5](#) Circuit

A value of $R = 75 \Omega$ (blue traces in [Figure 9](#)) is suitable because this value produces the most desirable response in terms of gain peaking and settling speed. The value is also compliant with [Equation 5](#).

3 Properties of Closed-Loop Amplifier Output Impedance (Z_{OUT})

Z_{OUT} is the frequency-dependent Thévenin equivalent impedance offered to a load by a closed-loop amplifier. Z_{OUT} is measured using the test circuit depicted in Figure 10, and is derived by replacing Z_{BLOCK} in Figure 1 with the closed-loop amplifier model, consisting of an op amp and a feedback network.

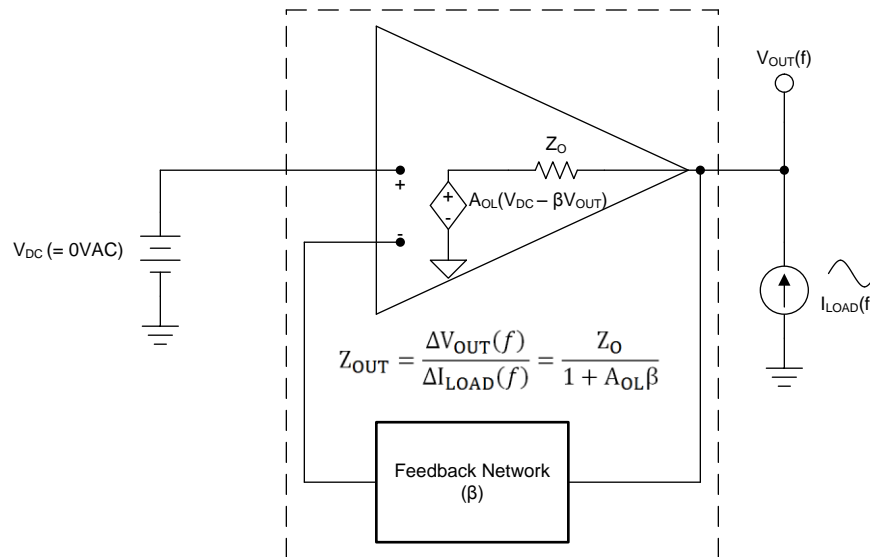


Figure 10. Z_{OUT} Test Circuit

A_{OL} is the amplifier open-loop voltage gain, and β is the voltage gain of the feedback network.

Z_O is the op amp open-loop output impedance. Writing ac node equations (similar to Equation 3) based on Figure 10, and solving for the gain ($\Delta V_{OUT} / \Delta I_{LOAD}$) produces Equation 6.

$$\begin{aligned} \Delta V_{OUT} &= -A_{OL}\beta \times \Delta V_{OUT} + \Delta I_{LOAD} \times Z_O \\ \Rightarrow Z_{OUT}(f) &= \frac{\Delta V_{OUT}(f)}{\Delta I_{LOAD}(f)} = \frac{Z_O}{1 + A_{OL}\beta} \end{aligned} \quad (6)$$

The following observations can be made based on Equation 6.

- Any changes in amplifier stability affecting loop gain ($A_{OL}\beta$) also affect Z_{OUT} . Therefore, Z_{OUT} can be used to assess amplifier stability.
- The frequency response of Z_{OUT} can be derived from the amplifier $A_{OL}\beta$ and Z_O transfer functions. Familiarity with commonly occurring Z_{OUT} regions over frequency is important for analyzing amplifier load transient behavior

A simple amplifier model can be constructed to explore the effects of loop gain and Z_O on Z_{OUT} . For ease of analysis, β is assumed to be constant so that loop gain is determined by A_{OL} alone. A_{OL} can be represented using the dominant pole approximation given by Equation 7.

$$A_{OL}(s) = \frac{A_{OL}(0) \times 2\pi f_{P1_AOL}}{s + 2\pi f_{P1_AOL}}$$

where

- $A_{OL}(0)$ is the amplifier dc open-loop gain.
- $s = -2\pi f_{P1_AOL}$ is the dominant pole of the A_{OL} transfer function.
- $(A_{OL}(0) \times 2\pi f_{P1_AOL})$ is the amplifier gain-bandwidth product. (7)

Substituting Equation 7 into Equation 6 and simplifying yields Equation 8.

$$Z_{OUT} = \frac{Z_O}{1 + A_{OL}\beta} = \frac{Z_O}{1 + \frac{A_{OL}(0)\beta \times 2\pi f_{P1_AOL}}{s + 2\pi f_{P1_AOL}}}$$

$$Z_{OUT} = Z_O \times \frac{s + 2\pi f_{P1_AOL}}{s + 2\pi f_{P1_AOL} \times (1 + A_{OL}(0)\beta)}$$
(8)

Observe that Z_{OUT} has:

- a real zero at $s_{Z_ZOUT} = -2\pi f_{P1_AOL}$ corresponding to $f_{Z_ZOUT} = f_{P1_AOL}$
- a real pole at $s_{P_ZOUT} = -2\pi f_{P1_AOL} (1 + A_{OL}(0)\beta)$ corresponding to $f_{P_ZOUT} = f_{P1_AOL} \times (1 + A_{OL}(0)\beta)$
- $f_{Z_ZOUT} < f_{P_ZOUT}$

Additional poles or zeros may be present based on the characteristics of Z_O . As described in *Modeling the output impedance of an op amp for stability analysis*, Z_O can be some combination of the fundamental impedances: resistive, capacitive or inductive. Therefore, Equation 8 can be examined under each of these three Z_O conditions.

1. If Z_O is purely resistive then Z_{OUT} contains no additional poles or zeros and has the general frequency characteristics described in Table 4.

Table 4. Z_{OUT} for Resistive Z_O and Single-Pole A_{OL}

Z_{OUT}	Frequency Range
Resistive	$0 < f < f_{Z_ZOUT}$
Inductive	$f_{Z_ZOUT} < f < f_{P_ZOUT}$
Resistive	$f > f_{P_ZOUT}$

2. If Z_O is purely capacitive ($Z_O = 1 / (sC)$), then Z_{OUT} contains an additional pole at $f = 0$, and has the general frequency characteristics described in Table 5.

Table 5. Z_{OUT} for Capacitive Z_O and Single-Pole A_{OL}

Z_{OUT}	Frequency Range
Capacitive	$0 < f < f_{Z_ZOUT}$
Resistive	$f_{Z_ZOUT} < f < f_{P_ZOUT}$
Capacitive	$f > f_{P_ZOUT}$

3. If Z_O is purely inductive ($Z_O = sL$), then Z_{OUT} contains an additional zero at $f = 0$, and has the general frequency characteristics described in Table 6.

Table 6. Z_{OUT} for Inductive Z_O and Single-Pole A_{OL}

Z_{OUT}	Frequency Range
Inductive	$0 < f < f_{Z_ZOUT}$
Double Inductive	$f_{Z_ZOUT} < f < f_{P_ZOUT}$
Inductive	$f > f_{P_ZOUT}$

The term *double inductive* denotes a Z_{OUT} region with a +40-dB/decade slope in magnitude. A double-inductive impedance can only occur in an active circuit using negative feedback, but modeling the impedance as a passive element in a combination is useful for stability analysis. On a linear frequency scale, the magnitude of Z_{OUT} in the double-inductive region increases as $(\Delta f)^2$ for a Δf change in frequency. Thus, the impedance transfer function of a double-inductive element (L_D) is $Z_{LD} = s^2 L_D$.

The effects of amplifier Z_O and A_{OL} on Z_{OUT} can be validated through simulation. Figure 11 shows a single-pole op amp A_{OL} model with a dc gain of 100,000 V/V (or 100 dB), and a single dominant pole at 15.9 Hz. Z_O has been initialized to 0 Ω . The 1-GH inductor makes sure that the circuit is in closed-loop configuration for dc convergence, and in open-loop configuration for ac-gain measurement. The 1-GF capacitor keeps the inverting input of the op amp from floating when the feedback loop is broken.

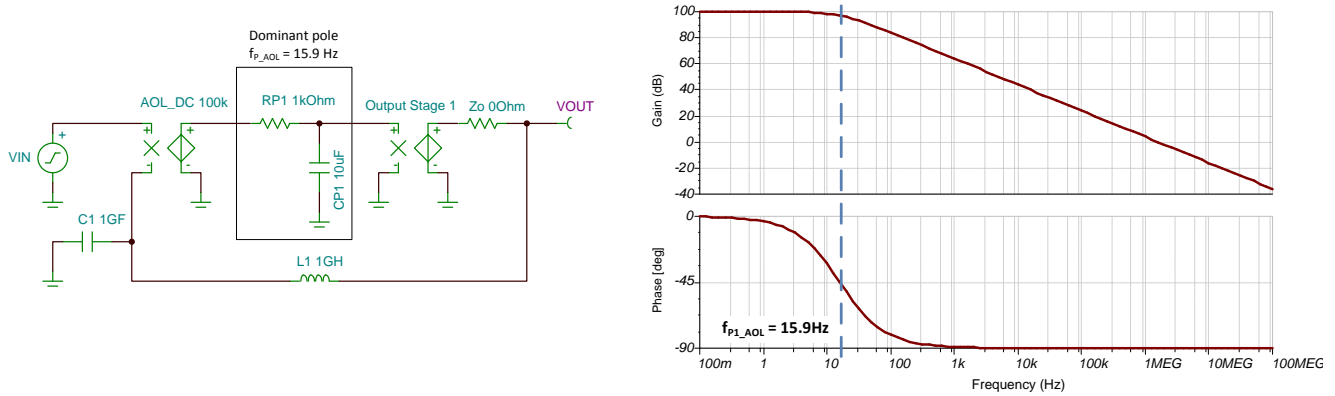


Figure 11. Op Amp A_{OL} Model With a Single Pole

For measuring Z_{OUT} , the amplifier must be in closed-loop gain configuration with the appropriate Z_O element, and excited with an ac current source according to Figure 10. Using $\beta = 1$ V/V for ease of analysis, the circuits of Figure 12 through Figure 14 depict Z_{OUT} versus frequency for the three basic Z_O types. $f_{z_ZOUT} = f_{P1_AOL} = 15.9$ Hz and $f_{P_ZOUT} = f_{P1_AOL} (1 + A_{OL}(0)\beta) = 1.59$ MHz.

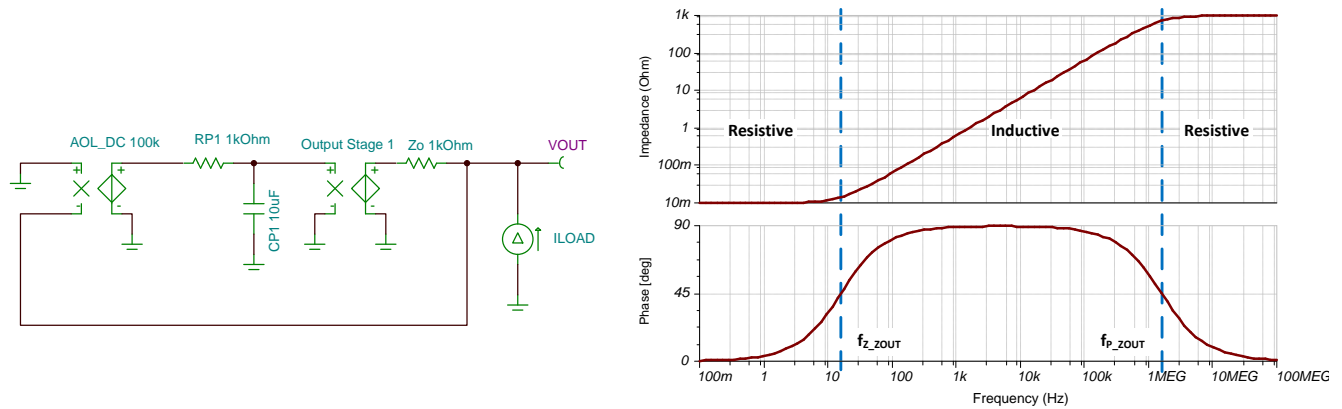


Figure 12. Z_{OUT} Simulation With Single-Pole A_{OL} and Resistive Z_O

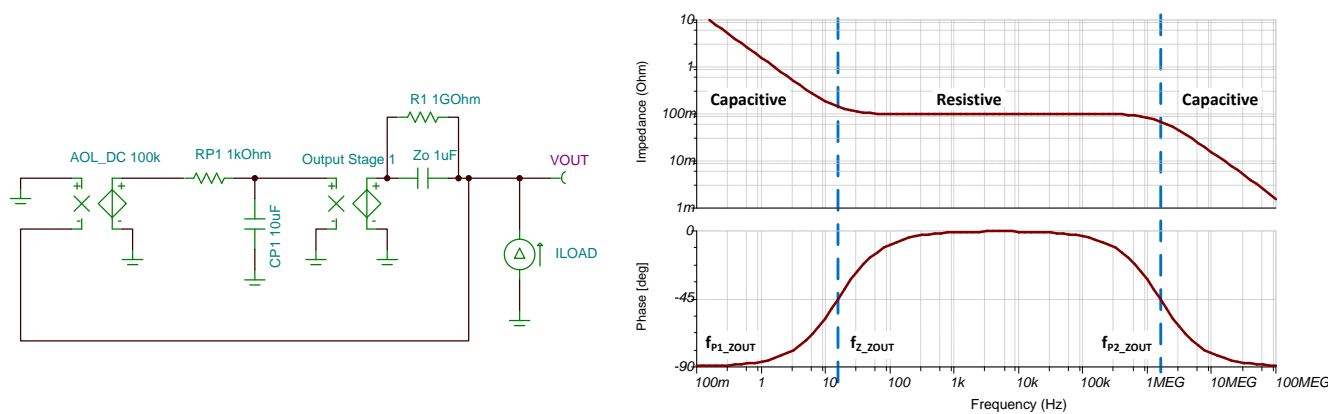


Figure 13. Z_{OUT} Simulation With Single-Pole A_{OL} and Capacitive Z_O

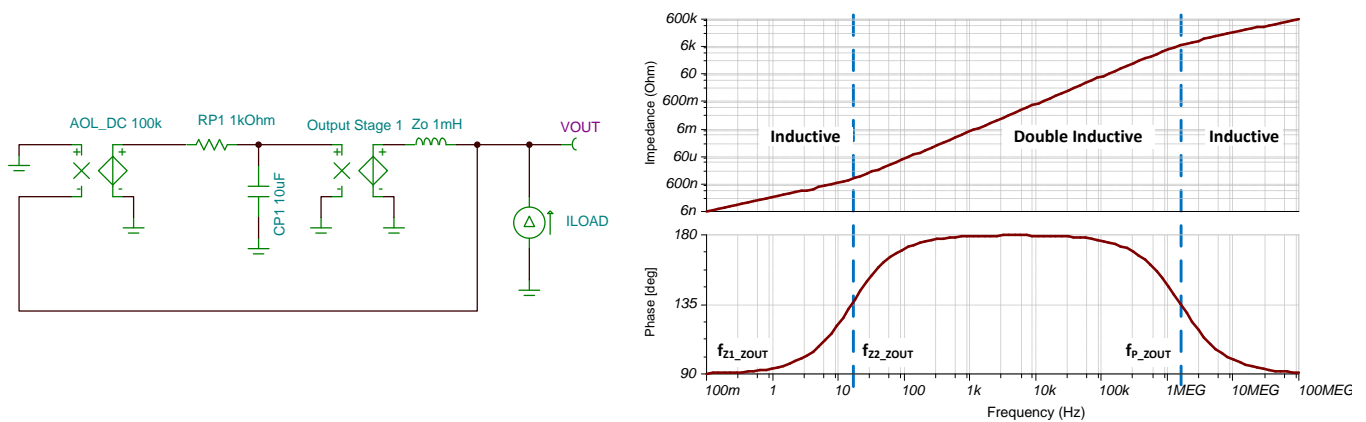


Figure 14. Z_{OUT} Simulation With Single-Pole A_{OL} and Inductive Z_O

4 Stability Analysis of a Loaded Amplifier Using Z_{OUT} and Z_{LOAD}

The stability of a loaded amplifier can be evaluated by examining the Thévenin equivalent impedance (Z_{EQ}) for complex poles. Z_{EQ} for a loaded amplifier is simply the parallel combination of Z_{OUT} and Z_{LOAD} , as shown in Equation 9:

$$Z_{EQ} = Z_{OUT} \parallel Z_{LOAD}$$

where

- Z_{OUT} can be resistive, capacitive, inductive or double inductive over frequency.
 - Z_{LOAD} can be resistive, inductive, or capacitive over frequency
- (9)

Therefore, the properties of Z_{EQ} can be studied by considering the various combinations of Z_{OUT} and Z_{LOAD} . Obviously, a resistive Z_{OUT} requires no special consideration because a resistive Z_{OUT} is unconditionally stable with any resistive or reactive Z_{LOAD} . From a stability perspective, only reactive Z_{OUT} regions are relevant when combined with specific Z_{LOAD} elements, as discussed in subsequent sections.

4.1 Inductive Z_{OUT} Driving a Capacitive Z_{LOAD} or Capacitive Z_{OUT} Driving an Inductive Z_{LOAD}

This section analyzes stability issues caused by LC interactions between Z_{OUT} and Z_{LOAD} . The analysis is the same regardless of which element is inductive and which is capacitive. In this case, however, the analysis focuses on the more common scenario where Z_{OUT} is inductive and Z_{LOAD} is capacitive. Both conditions produce complex conjugate poles in Z_{EQ} . The circuit shown in Figure 15 is a typical example.

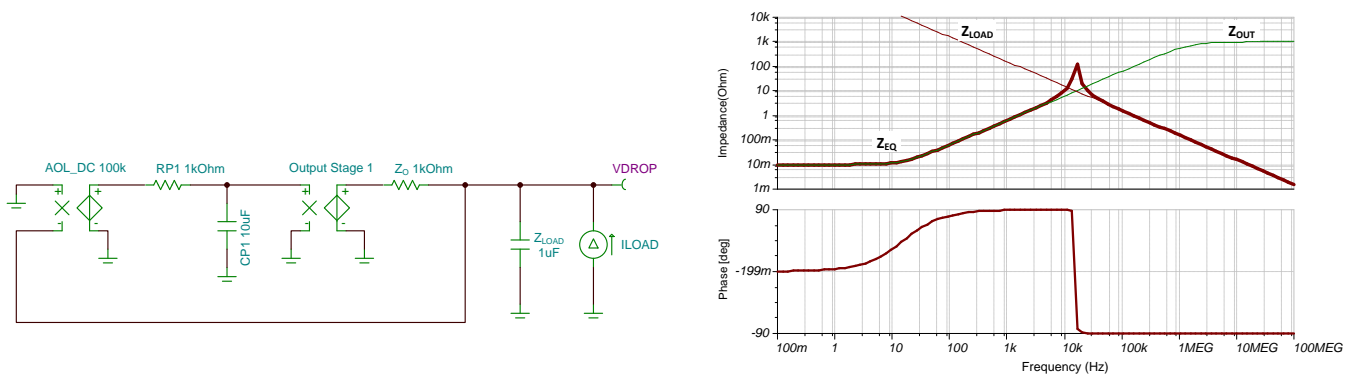


Figure 15. Example of Circuit With Resonant LC Interaction Between Z_{OUT} and Z_{LOAD}

With the individual impedances superimposed, tracing the path of the lower impedance reveals a peak in the Z_{EQ} magnitude plot around the $Z_{OUT} - Z_{LOAD}$ matching frequency. The peak signifies complex conjugate poles and the oscillatory load transient response is shown in Figure 16.

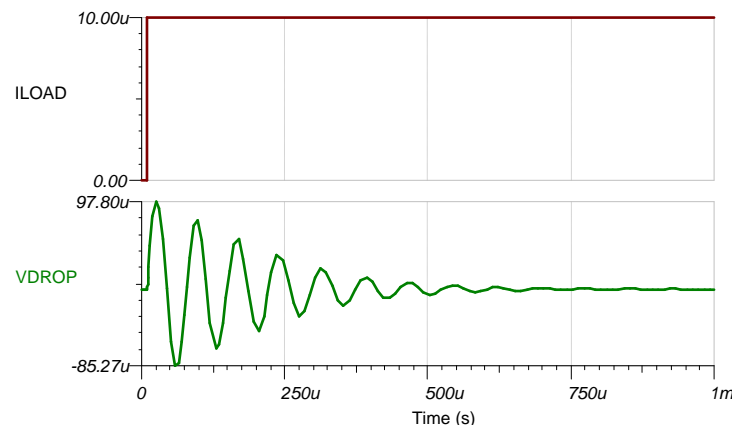


Figure 16. Unstable Load Transient Response of Circuit in Figure 15

As discussed in Section 2.5, an LC resonant peak in Z_{EQ} can be eliminated by adding sufficiently large series resistance: $R \geq 2 \times \sqrt{L/C}$ (see Equation 5). While the circuit diagram shows the value of C (= Z_{LOAD}), the value of L must be calculated using the Z_{OUT} magnitude plot by identifying a point in the inductive region. Observing that $|Z_{OUT}| \approx 50 \text{ m}\Omega$ at $f = 75 \text{ Hz}$, the value of L can be calculated as $L = |Z_{OUT}| / (2\pi f) \approx 106 \text{ }\mu\text{H}$. Thus, the required resistance value for stability is $R \geq 20.6 \text{ }\Omega$. Stabilized responses are shown in Figure 17 and Figure 18. Clearly, a value of R in the 20- Ω to 30- Ω range is suitable.

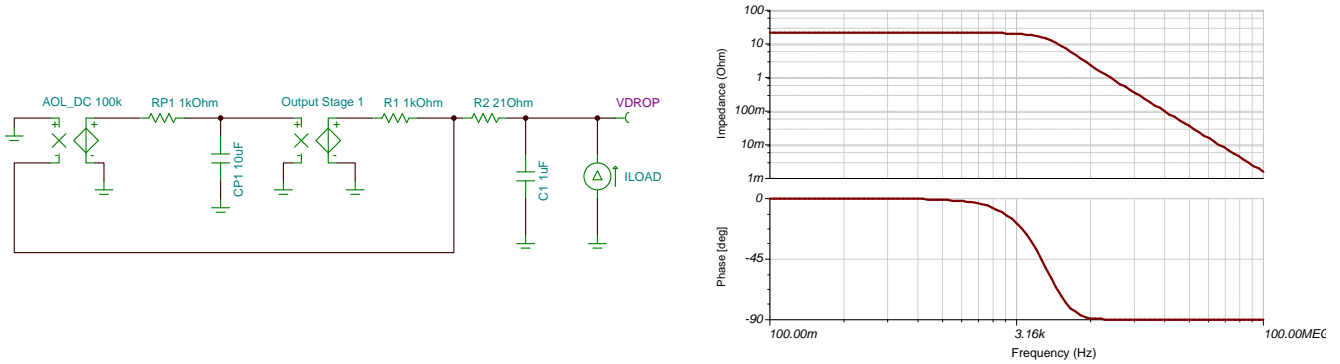


Figure 17. Adding Series Resistance Eliminates LC Resonant Peak in Z_{EQ}

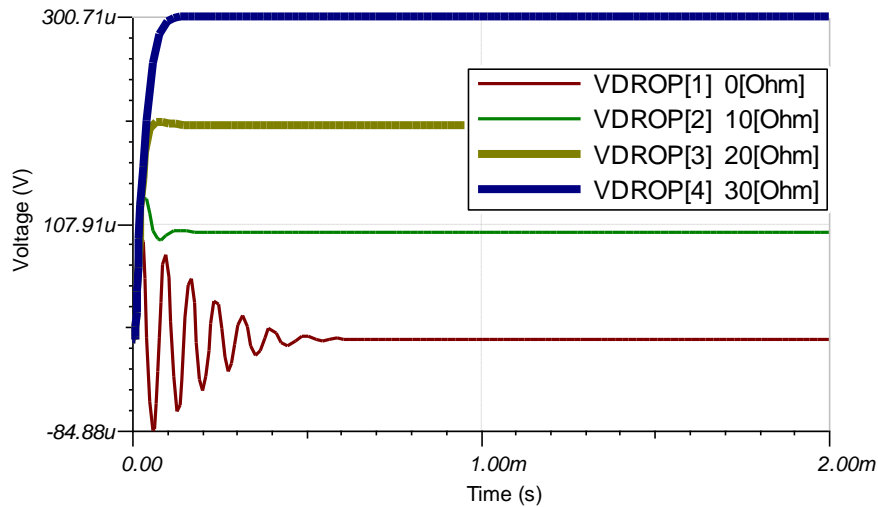


Figure 18. Load Transient Response of Figure 17 Circuit is Stable for $20 \text{ }\Omega < R < 30 \text{ }\Omega$

The series resistance creates a steady-state dc error, and takes several milliseconds to settle, which may not be acceptable in some applications. A simple workaround is to move the resistor in series with the load capacitor, as shown in Figure 19.

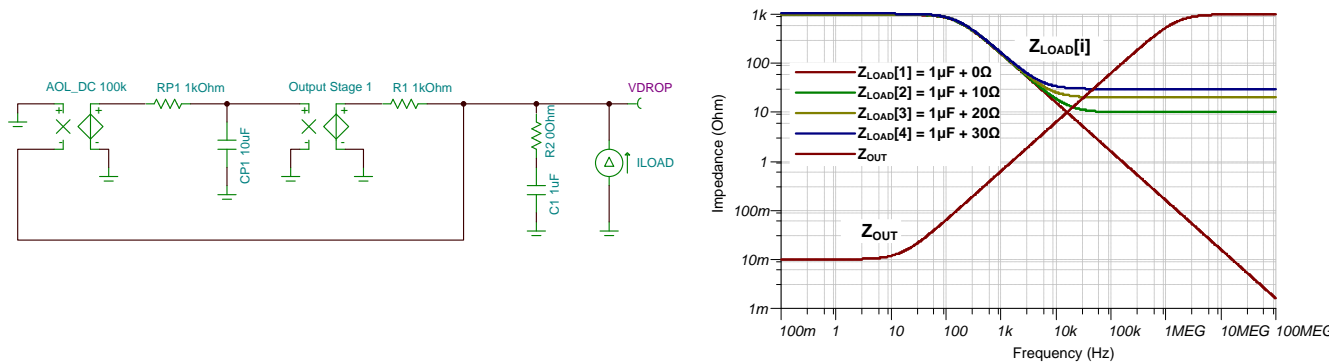


Figure 19. Increasing ESR Also Eliminates Resonant LC Peak in Z_{EQ}

There is still a stability improvement because, as shown in Figure 19, the added ESR makes Z_{LOAD} more resistive around the $Z_{OUT} - Z_{LOAD}$ matching frequency, thereby eliminating resonance. Figure 20 depicts the load transient response as ESR is increased.

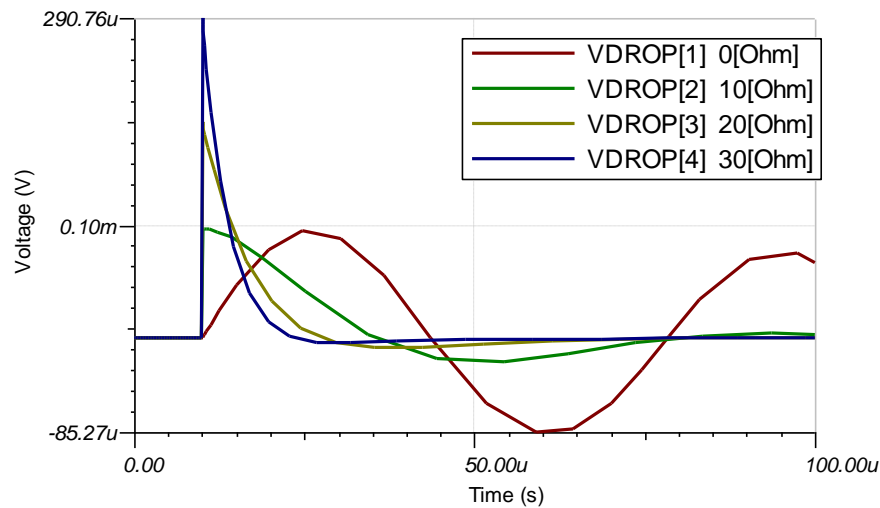


Figure 20. Load Transient Response With Increasing Z_{LOAD} ESR

Observe that the response becomes increasingly stable, and the dc steady-state error as well as settling time become negligible. However, the peak overshoot becomes progressively higher as the capacitor initially sinks most of the load current (a positive step function, in this case), generating a bigger voltage drop across the ESR. This overshoot may be acceptable in applications where dc accuracy and fast settling are more important.

4.2 Double-Inductive Z_{OUT} Driving Resistive Z_{LOAD}

Figure 21 shows the model of a circuit with a double-inductive Z_{OUT} driving a resistive Z_{LOAD} .

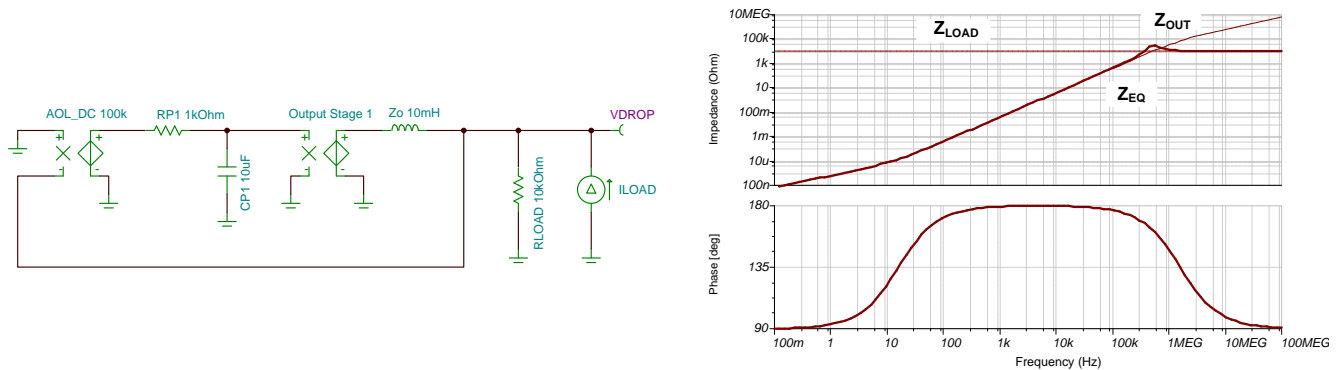


Figure 21. Example Circuit Showing Double-Inductive Z_{OUT} Driving Resistive Z_{LOAD}

There is no LC resonance in this case; however, Z_{EQ} has an unexpected peak around the $Z_{OUT} - Z_{LOAD}$ matching frequency, and the load step response is unstable, as shown in Figure 22.

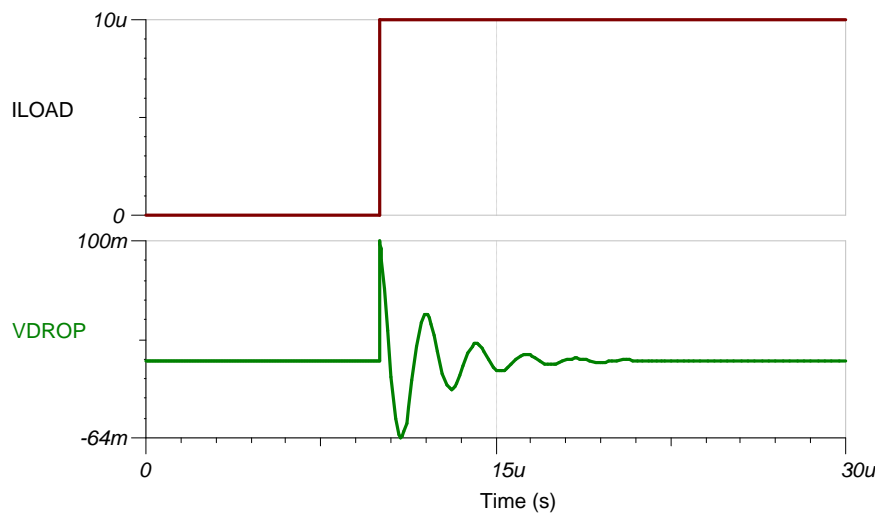


Figure 22. Unstable Load Transient Response of Figure 21 Circuit

For stability analysis in this case, the Z_{EQ} transfer function must be solved algebraically.

Equation 10 expresses Z_{EQ} as the combination of inductive (L_1 , L_2) and double-inductive (L_D) portions of Z_{OUT} with resistive $Z_{LOAD} = R_{LOAD} = 10 \text{ k}\Omega$. L_2 can be eliminated from the expression for Z_{EQ} because R_{LOAD} dominates Z_{EQ} at high frequencies.

$$Z_{EQ} = Z_{OUT} \parallel Z_{LOAD} = ((sL_1 + s^2L_D) \parallel sL_2) \parallel R_{LOAD} \approx (sL_1 + s^2L_D) \parallel R_{LOAD} \quad (10)$$

$$\Rightarrow Z_{EQ}(s) = \frac{sR_{LOAD}(L_1 + sL_D)}{R_{LOAD} + s(L_1 + sL_D)}$$

$$\text{Poles} \Rightarrow \text{Denominator}(Z_{EQ}(s)) = 0$$

$$\Rightarrow s^2L_D + sL_1 + R_{LOAD} = 0$$

$$\therefore s_{p1,p2} = -\frac{L_1}{2L_D} \pm \sqrt{\left(\frac{L_1}{2L_D}\right)^2 - \frac{R_{LOAD}}{L_D}} \quad (11)$$

Substituting the values of $L_1 = 132 \text{ nH}$ and $L_D = |Z_{OUT}|/(2\pi f)^2 \approx 1 \text{ n units}$ (from the Z_{OUT} Bode plot) confirms that Z_{EQ} has a pair of complex conjugate LHP poles near the $Z_{OUT} - Z_{LOAD}$ matching frequency of approximately 500 kHz.

$$s_{p1,p2} = (-130 \pm j3.13M) \frac{\text{rad}}{\text{s}}$$

$$\therefore f_{p1,p2} = \frac{|\text{Im}(s_{p1,p2})|}{2\pi} = 498 \text{ kHz}$$

Stabilizing the load transient response requires the quantity under the square root in Equation 11 to be positive

$$\left(\frac{L_1}{2L_D}\right)^2 - \frac{R_{LOAD}}{L_D} \geq 0$$

$$\Rightarrow L_1 \geq 2 \times \sqrt{R_{LOAD} \times L_D} = 6.4 \text{ mH} \tag{12}$$

Equation 12 suggests that the complex poles can be eliminated by increasing the value of L_1 , which is equivalent to adding series inductance to Z_{OUT} . According to Figure 23, the oscillatory response disappears when the value of the series inductance exceeds 6 mH. Figure 24 shows how adding series inductance eliminates the double-inductive characteristic of Z_{EQ} .

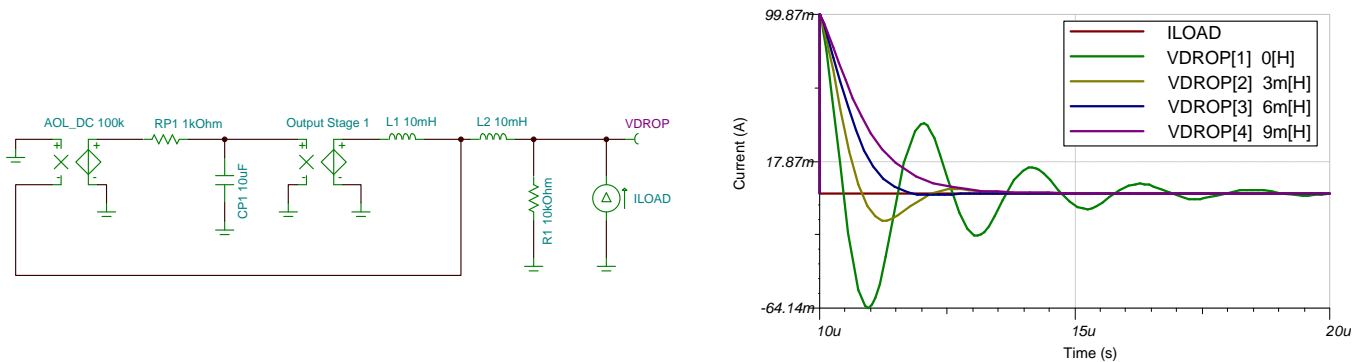


Figure 23. Adding Series Inductance to Z_{OUT} Stabilizes Load Step Response

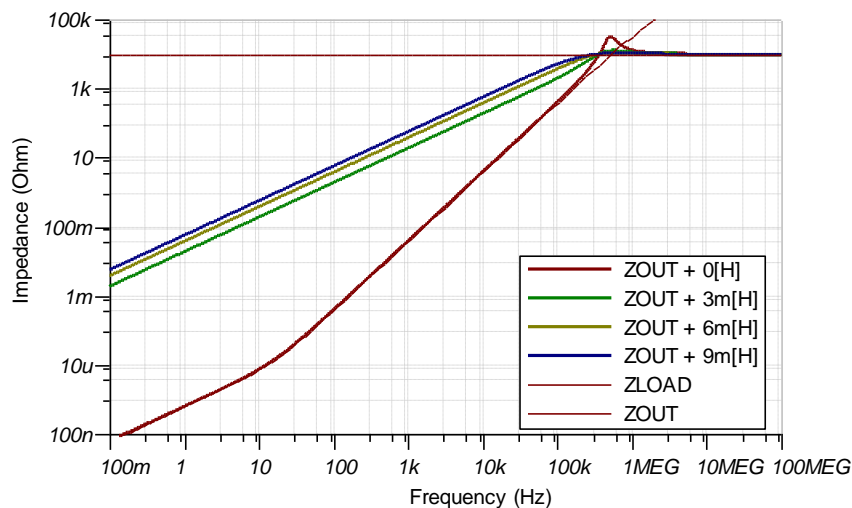


Figure 24. Double-Inductive Region No Longer Dominates Z_{OUT} With Higher ESL

4.3 Double-Inductive Z_{OUT} Driving Capacitive Z_{LOAD}

The Z_{EQ} Bode plots for this configuration show signs of gross instability. According to the magnitude plot of Figure 25, there are three poles corresponding to the $Z_{OUT} - Z_{LOAD}$ matching frequency, but phase lead increases sharply by 90° in just one octave around the matching frequency. Table 2 shows that this signature represents a pair of complex conjugate RHP poles that produce an exponentially increasing oscillatory response, as confirmed by Figure 26.

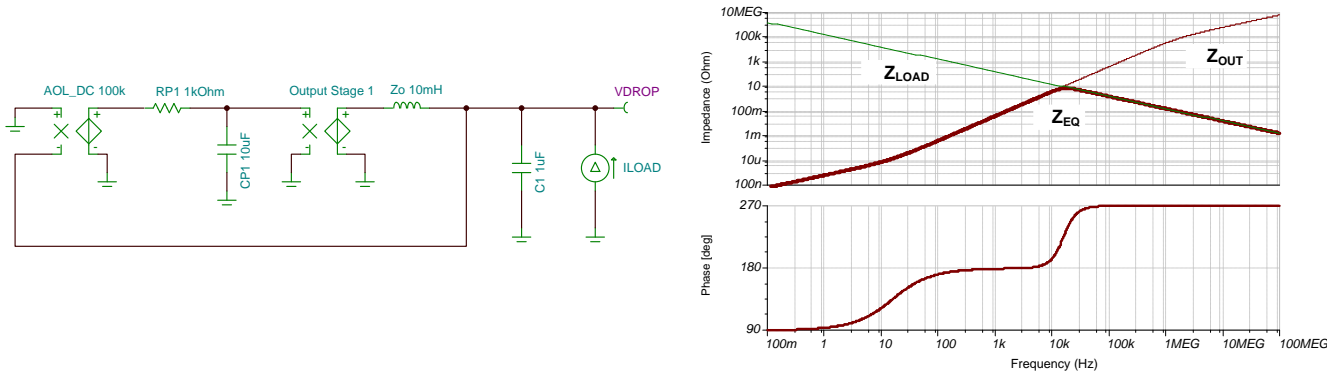


Figure 25. Example Circuit With Double-Inductive Z_{OUT} Driving Capacitive Z_{LOAD}

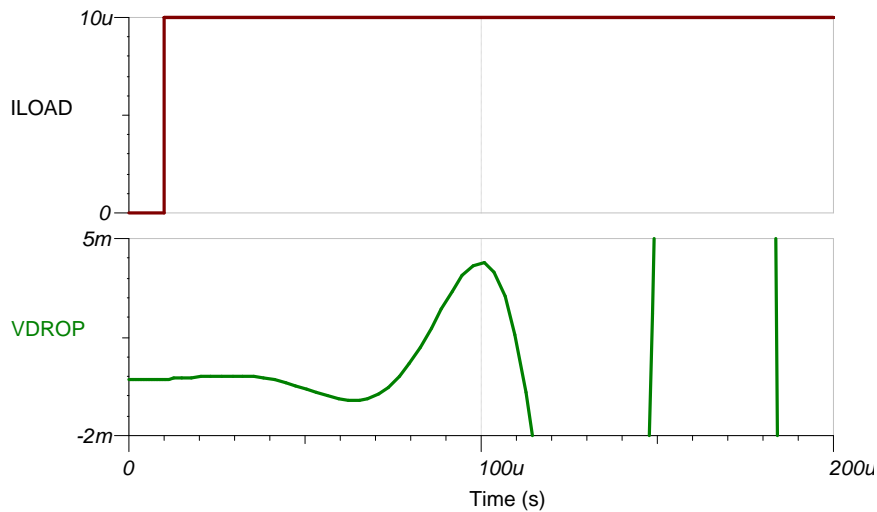


Figure 26. Unstable Load Step Response of Figure 25 Circuit

In this case, it is difficult to find the poles of Z_{EQ} algebraically because this case involves solving a third-order polynomial equation, which is nontrivial. For reference, the Z_{EQ} transfer function is given by Equation 13.

$$Z_{EQ} = Z_{OUT} \parallel Z_{LOAD} = \left((sL_1 + s^2L_D) \parallel sL_2 \right) \parallel \frac{1}{sC_{LOAD}} \approx (sL_1 + s^2L_D) \parallel \frac{1}{sC_{LOAD}}$$

$$\Rightarrow Z_{EQ}(s) = \frac{s^2L_D + sL_1}{s^3L_D C_{LOAD} + s^2L_1 C_{LOAD} + 1} \quad (13)$$

In lieu of an algebraic analysis, the strategies discussed in Section 4.1 and Section 4.2 can be applied. The basic idea is to add series inductance so that Z_{OUT} transforms into being more inductive around the $Z_{OUT} - Z_{LOAD}$ matching frequency. Consequently, the circuit simplifies to an LC resonant circuit that can then be stabilized relatively easily by adding series resistance.

From the Bode plot $|Z_{OUT}| \approx 10 \Omega$ at the $Z_{OUT} - Z_{LOAD}$ matching frequency (f_p) of approximately 16 kHz. For Z_{OUT} to become more inductive, the impedance of the series inductor at 16 kHz must be higher than 10Ω . Use Equation 14 to select a suitable value.

$$L_1 > \frac{2 \times |Z_{OUT}(f_p)|}{2\pi f_p} \approx 200 \mu\text{H} \tag{14}$$

The value of the series resistance required to eliminate the resonant peak appearing in Figure 27 can now be calculated using Equation 5: $R \geq 2 \times \sqrt{L_1/C_{LOAD}} \approx 30 \Omega$. Figure 28 and Figure 29 depict the Bode plot and transient response of the stabilized circuit, respectively.

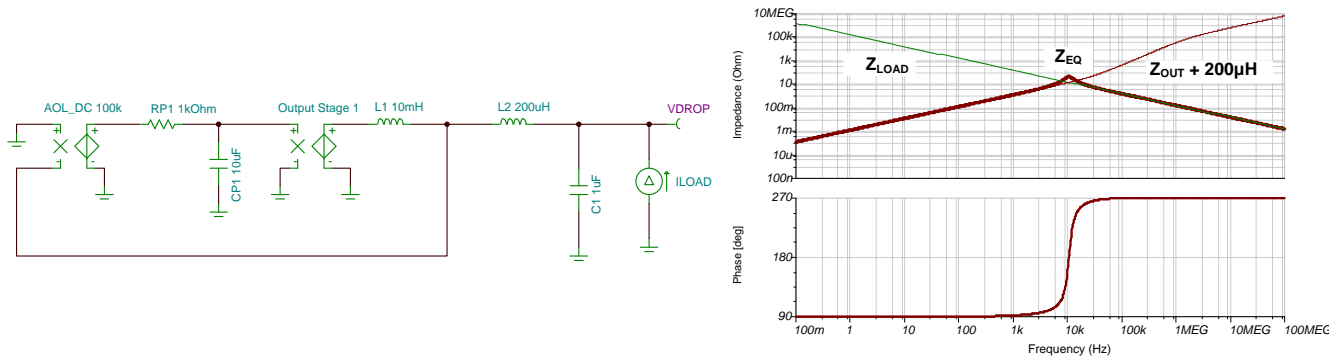


Figure 27. Modified Z_{OUT} is More Inductive Around $f_p = 16 \text{ kHz}$

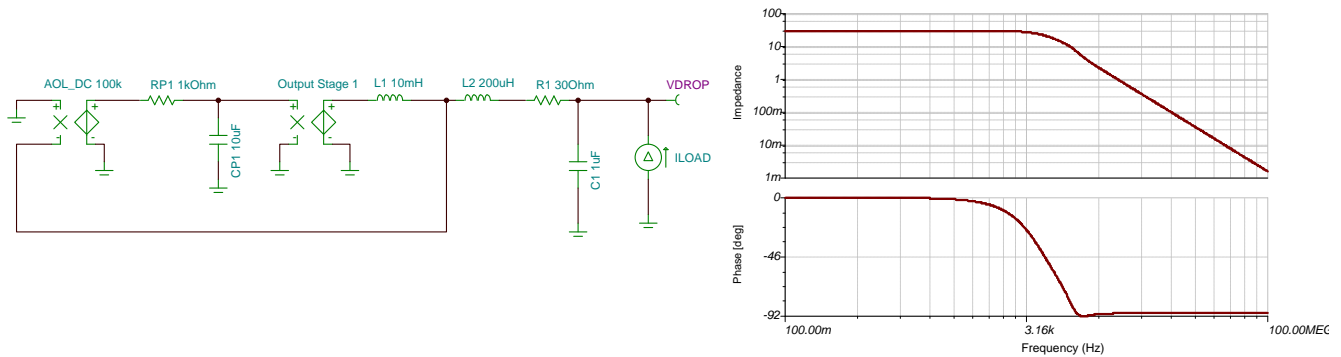


Figure 28. Adding Series Resistance Eliminates Peak in Modified Z_{EQ} Magnitude

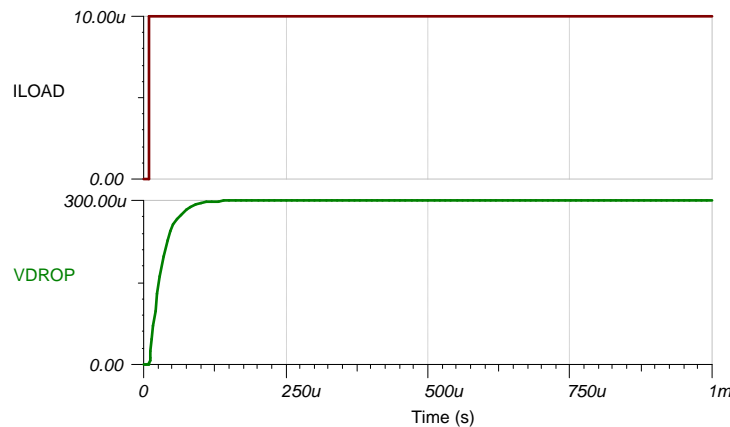


Figure 29. Load Step Response of Stabilized Circuit

Finally, the compensation strategies presented in this article must be considered alongside other system constraints such as cost, component availability, performance, and so on. For example, introducing a low-cost op amp buffer between the amplifier and load capacitor in the circuit shown in [Figure 25](#) could be more cost-effective and enable faster settling across the load capacitor than using a 200- μ H inductor for compensation. However, an op amp buffer would likely also consume more board area and supply current, and introduce additional errors in the signal path, thus requiring careful consideration against design objectives.

5 Conclusions

The closed-loop output impedance (Z_{OUT}) of an amplifier makes it possible to evaluate the stability of the amplifier load transient response under closed-loop conditions.

A stable load transient response is characterized by exponential settling to steady state without ringing. This requires a Thévenin equivalent impedance function that has purely real poles in the left half of the complex s-plane (LHP).

Simple amplifier simulation models constructed using the dominant pole A_{OL} approximation provide useful insights into the frequency response of Z_{OUT} and the various impedance profiles offered to a load.

Compensation strategies were developed using algebraic and geometric methods to overcome load transient stability issues for various amplifier Z_{OUT} and load configurations. These strategies were validated through simulation.

6 References

- Texas Instruments, [Solving Op Amp Stability Issues Wiki](#)
- Texas Instruments, [Modeling the Output Impedance of an Op Amp for Stability Analysis Analog Applications Journal](#)
- Massachusetts Institute of Technology – Department of Mechanical Engineering, 2.14 Analysis and Design of Feedback Control Systems, [Understanding Poles and Zeros](#)

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